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Influence of beam-hardening of polychromatic x-ray photon beams

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Monitoring moisture movements in building materials using x-ray attenuation: Influence of beam-hardening of polychromatic x-ray photon beams

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Abstract

X-ray attenuation measurements are commonly used as a non-destructive method to monitor internal concentration changes of moisture (i.e., moisture content) and other chemical compounds in porous building materials. The technique provides direct measurements of moisture content changes through analysis with a composite model consisting of a dry porous material and a thickness of water equivalent to the moisture content of the material. The current formulation of this composite model relies on certain assumptions, including a monochromatic x-ray photon beam source (i.e., x-ray photons of a single, consistent energy) and that interactions between the x-ray photons and the materials (water and porous material) are independent. However, x-ray sources typically used by researchers in this field of study produce x-ray photon beams over a spectrum of energy levels, or polychromatic x-ray photons. Implications of this inconsistency are introduced and discussed. This paper presents both an overview of fundamental descriptions of the x-ray attenuation measurement technique and results from a parametric experimental study of various porous construction materials, including calcium silicate board, aerated autoclaved concrete, clay brick, cementitious materials, and wood. Results from the parametric investigation indicate the attenuation coefficient of water is dependent on the type and thickness of the porous material.

Keywords: Moisture content, X-ray, Attenuation coefficient, Porous media

1. Introduction

Moisture, and more specifically varying moisture conditions, often significantly affects structural performance and durability of construction materials. For example, moisture movements may affect warping of timber studs [1], workability [2] and plastic cracking [3] of fresh cementitious materials, maturation of bond strength of lime mortars [4], aging of bitumen binders [5], freeze-thaw damage of concretes [6], etc. Furthermore, moisture influences various chemical, biological and thermal characteristics of materials. In general, moisture and moisture movements are key determining factors in the durability of structures constructed from a multitude of materials. Therefore, experimental approaches for accurate non-destructive monitoring of moisture conditions are essential. Various non-destructive methods are available [7]; however, x-ray attenuation measurements are emerging as a popular technique for monitoring moisture movements in various porous materials, particularly in cracked materials [8–21]. Measurement speed and resolution, ease of two-dimensional (or three-dimensional [22]) imaging, availability of facilities, and direct measurement of changes in moisture content are key advantages.

X-ray technologies are commonplace in the medical and security fields; however, application of x-ray attenuation measurements for monitoring of moisture movements in porous media is relatively complex. Changes in moisture content necessitate comparison of multiple x-ray measurements captured at different states (i.e., times). Currently, descriptions of basic and fundamental controlling mechanisms and influential factors are somewhat lacking.

Quantification of moisture content in porous materials from x-ray attenuation measurements is achieved by decomposing a water-containing (saturated or partially saturated) porous material into a dry porous material of the same thickness and a water layer with a thickness...
equivalent to the moisture content [14, 16–18, 20]. Using the composite system, equations have been derived allowing for calculation of moisture content changes from x-ray measurements taken at different states. The derived expressions however depend upon certain assumptions. Firstly, calculations assume the incoming x-ray photons are of a single, constant energy. Secondly, the quantification of moisture content in porous materials via x-ray attenuation is based on a non-interacting composite concept where the attenuation of x-ray photons provided by the porous material and the water are assumed independent. This paper demonstrates these assumptions are not generally valid, and that the interaction between material and water needs to be accounted for to accurately quantify moisture contents in porous materials via x-ray attenuation. Further, the common use of polychromatic x-ray source, which produce x-ray photons over a spectrum of energies, needs to be accounted for to accurately quantify moisture contents in porous materials via x-ray attenuation.

The first section of the paper summarizes the physics of x-ray attenuation, including both monochromatic and polychromatic x-ray photon beams. Key terminology and common misconceptions within the civil/materials engineering communities, particularly the various definitions of attenuation coefficient, are introduced. In the remaining section the composite concept typically utilized to relate changes in x-ray photon counts to changes in moisture content is challenged. Factors affecting the composite concept, including primarily beam hardening and the resulting dependence of the attenuation coefficient of water on the ‘parent’ material, are discussed. While specific results presented are dependent on the type of materials investigated (calcium silicate board, aerated autoclaved concrete, clay brick, cementitious materials, and wood here) and also likely on the x-ray system used, vital conclusions on and potential pitfalls of the general measurement technique are discussed in this paper.

2. Fundamentals of the x-ray attenuation measurement technique

Fig. 1(a) illustrates the required equipment and the behaviour of an x-ray photon beam during x-ray attenuation measurements. For such measurements a specimen is placed between an x-ray source, which produces a conical beam of x-ray photons, and an x-ray detector (camera used here). Additional details on the interactions between x-ray photons and the specimen are described in a following section. Fig. 1(b) illustrates the commonly accepted composite concept, consisting of a dry or partially saturated specimen and a thickness of water, to describe the effect moisture content changes have on x-ray attenuation measurements [8, 14, 16–18, 20, 23]. Using this composite system along with several assumptions, a relationship can be derived to convert changes in x-ray photon counts to changing moisture content of porous materials. One key assumption in the derivation this relationship is that the porous material does not impact the x-ray attenuation provided by water, and vice versa; therefore, the model illustrated in Fig. 1(b) is referred to as a 'non-interacting' composite concept. The following sections describe the x-ray attenuation measurement technique in detail, provide the derivation the photon count-moisture content relationship, and introduce other common assumptions.

2.1. Interactions between x-ray photons and building materials

As illustrated in Fig. 1(a) an x-ray photon beam with an initial intensity, \( I_0 \), is produced by an x-ray source and passes through a specimen. A portion of the photons interact with the specimen, reducing the initial intensity to the transmitted intensity, \( I \). The reduction in intensity for a monochromatic x-ray photon beam (i.e., photons of single and constant energy) is described by Eq. 2:

\[
\frac{dI(x)}{dx} = -\mu \cdot I(x)
\]

or in the more common form, known as the Beer-Lambert law [24]:

\[
I = I_0 \cdot e^{-\mu \cdot t}
\]

where \( \mu \) is the linear attenuation coefficient \([m^{-1}]\), \( I(x) \) is the number of x-ray photons present at depth \( x \), and \( t \) is the thickness of the specimen \([m]\). The units for intensity are counts or hits, simply indicating the number of x-ray photons.

The linear attenuation coefficient, \( \mu \), is equivalent to the total probability of x-ray photon-material interaction per unit length of a material. An x-ray photon passing through a building material may interact on the atomic level in one of three ways – photoelectric effect, Compton scatter, or pair production [25]. Eq. 2 defines \( \mu \) therefore as:

\[
\mu(E, Z_{eff}, \rho) = \tau(E, Z_{eff}, \rho) + \sigma(\rho) + \kappa(E \geq 1022 \text{ keV}, \ldots)
\]

where \( \tau, \sigma, \) and \( \kappa \) are the photoelectric, Compton, and pair production cross-sections \([m^{-1}]\), respectively, all of which are characteristics of the material through which x-ray photons are passing.
Figure 1: Schematic representation of a typical x-ray attenuation experimental setup. (a) illustrates the Beer-Lambert Law while (b) illustrates a composite experimental system consisting of a dry specimen and an amount of liquid water to represent movement of moisture.

The photoelectric effect describes one possible interaction between a photon and a bound atomic electron in the specimen, wherein the photon is absorbed and a photoelectron is produced. The probability of this interaction ($\tau$) increases with the effective atomic number, $Z_{\text{eff}}$ and density, $\rho$ [kg/m$^3$] of the specimen and decreases significantly with increased x-ray photon energy, $E$ [keV]. Compton scatter occurs when an x-ray photon collides with a free electron, causing a change in direction and reduction in energy of the photon. The probability of this interaction ($\sigma$) increases with $\rho$ and is slightly influenced by $E$ at energies far higher than typically used for the type of investigations discussed here [25]. Pair production, wherein the photon and an atomic nucleus interact to create an electron-positron, only occurs for $E > 1022$ keV (i.e., minimum kinetic energy required to initiate pair production) [25]. Such energies far exceed typically used x-ray source energy settings [8–23]. Therefore, for $E < 200$ keV the energy-, effective atomic number-, and density-dependent linear attenuation coefficient, $\mu$ can be described according to Eq. 4 [26–28]:

$$\mu(E, Z_{\text{eff}}, \rho) = \left(\frac{Z_{\text{eff}}^{3.8}}{E^b} + c\right) \cdot \rho$$

where $a$ and $c$ are coefficients describing the photoelectric and Compton cross-sections, respectively and $b$ describes the shape of the photoelectric cross-section curve. The first term of Eq. 4 is equivalent to the photoelectric cross-section, $\tau$ in Eq. 3, while the second term is equivalent to Compton cross-section, $\sigma$. The Compton cross-section is assumed to be photon energy-independent below 200 keV [26–28].

Fig. 2 shows fitting results of Eq. 4 against tabulated data on linear attenuation coefficients for liquid water, $\mu_w$, in [29]. Due to the photoelectric effect low energy x-ray photons are attenuated more efficiently, a trend inherent in all elements and compounds (see [e.g., 29]). Compton cross-section controls $\mu_w$-values for photon energies greater than approximately 26 keV.

2.2. Impact of polychromatic x-ray sources

The x-ray source utilized here (described in [8]) and sources utilized by others [7, 9–22] produce x-ray photons over a spectrum of energies (i.e., polychromatic) limited to the user-defined x-ray energy setting, $E_m$, as illustrated in Fig. 3(a). Furthermore, the x-ray camera used here, described below, and similar devices used by others [7, 14, 17, 18] detect only the presence of individual x-ray photons and not the energy of individual photons. The use of these non-energy discretizing x-ray cameras with a polychromatic x-ray source requires the introduction of an average attenuation coefficient, $\mu$ as discussed below. Further, the polychromatic x-ray source leads to so-called beam hardening [30] illustrated in Fig 3(b), which must be considered.
Fig. 3(a) illustrates a possible x-ray spectrum produced by an x-ray source, assuming an x-ray source energy (i.e., $E_m$) of 85 keV. The shape of the initial intensity spectrum presented in Fig. 3(a) comes from [31] where a photon energy detector measured the x-ray spectrum produced by the exact source utilized here. The shape of the photon energy spectrum, described by $\Psi_E(x)$, changes due to attenuation as it passes through increasing thicknesses, $x$ of material. To illustrate this effect, the transmitted spectrum was calculated by applying Eq. 2 at each x-ray energy level and using the fitted linear attenuation coefficients of water for a 15 mm thickness of water as shown in Fig. 3(b). Attenuation provided by the water progressively increases the average x-ray photon energy, meaning the remaining x-ray photons are ‘harder,’ hence the term beam hardening.

The x-ray camera used measures only the number of x-ray photons (i.e., intensity) as the sum of the area under the $\Psi_E(x)$-curve, as shown in Fig. 3(a) for an initial intensity, $I_0$. The x-ray camera does not distinguish between photons of varying energies. Therefore, relating the initial and transmitted intensities, $I_0$ and $I$ respectively, shown in Fig. 3(b) is not directly possible using Eq. 1 and 2. Eq. 1 must be modified, removing the linear attenuation coefficient, $\mu$ and introducing an average attenuation coefficient, $\bar{\mu}$ over the spectrum, $\Psi_E(x)$ [32, 33] defined by:

$$\bar{\mu} = \frac{\int_{0}^{E_m} \int \mu(E, Z_{eff}, \rho) \cdot \Psi_E(x) dE}{\int_{0}^{E_m} \Psi_E(x) dE}$$  

The x-ray spectrum, $\Psi_E(x)$, which can vary depending on x-ray source (see spectra provided in references [8, 12, 14, 18]), clearly influences the average attenuation coefficient. Fig. 3(c) shows calculated values of $\bar{\mu}$ as a function of water thickness, where the $\Psi_E(x)$-curves were calculated as previously described. The broken line in Fig. 3(c) indicates the value of the linear attenuation coefficient of water ($\mu_w$) at the x-ray source energy setting of 85 keV. The blue diamonds show the average attenuation coefficient for varying thickness of water, as calculated using Eq. 5. The calculations indicate average attenuation coefficients are potentially several orders of magnitude higher than linear attenuation coefficients. The average attenuation coefficient is asymptotic to the linear attenuation coefficient at the maximum x-ray photon energy as a sufficient thickness would attenuate all but the most energetic photons.

Due to beam hardening, $\bar{\mu}$ is no longer a constant, but varies with the location in the material. Fig. 4 illustrates the thickness-dependency of the average attenuation coefficients from measurements on concrete. The specimen thickness-dependency of the average attenuation coefficient can be described by Eq. 6 [32, 33]:

$$\bar{\mu}(t) = \frac{\mu_0}{(1 + \lambda \cdot t)^2} = \frac{\bar{\mu}(\Psi_E(0), Z_{eff}, \rho)}{(1 + \lambda \cdot t)^2}$$ (6)

where $\mu_0$ is the initial average attenuation coefficient [m$^{-1}$] and $\lambda$ is the beam hardening coefficient of the material [m$^{-1}$]. The initial average attenuation coefficient, $\mu_0$, may be considered the average attenuation coefficient of an infinitely thin section of material, indicating $\mu_0$-values must depend upon the initial x-ray spectrum, $\Psi_E(0)$. Further, based on Eq. 4, $\mu_0$-values also likely depend on the density ($\rho$) and effective atomic number ($Z_{eff}$) of the material. Therefore, the second definition for $\bar{\mu}$ is included in Eq. 6. Eqs. 4 and 5 provide a means to derive an expression for $\bar{\mu}(\Psi_E(0), Z_{eff}, \rho)$; however, solutions are complicated due to a singularity when the x-ray energy is 0 keV. Therefore, Eq. 7 is suggested as a possible means to relate $\mu_0$-values to the x-ray source energy setting, $E_m$ and material properties, based upon Eq. 4:

$$\mu_0 = \bar{\mu}(\Psi_E(0), Z_{eff}, \rho) = \left( a^* Z_{eff}^{2 \cdot 8} + b^* \right) \cdot \rho$$ (7)

where the terms $a^*$, $b^*$, and $c^*$ are analogous to $a$, $b$, and $c$ described in Eq. 4 for the initial average attenuation coefficient. The term $a^* Z_{eff}^{2 \cdot 8}$ can be replaced with a single variable, $\alpha$ to simplify fitting of experimental results presented later due to the complex stoichiometry of the materials tested. Values from Eq. 6 yield tangential
slopes of the solid red plot in Fig. 4; therefore, to simplify analysis the effective attenuation coefficient, \( \mu_{\text{eff}} \), is utilized.

The effective attenuation coefficient, \( \mu_{\text{eff}} [\text{m}^{-1}] \), is needed for use in the integrated Beer-Lambert law (Eq. 1) to describe the x-ray attenuation provided by a particular thickness of a material, as defined by Eq. 8:

\[
\mu_{\text{eff}} = \frac{\int \mu \, dx}{t} = \frac{\int \mu(E) \, dx}{t} = \frac{\int \mu(E) \, dx}{1 + \lambda \cdot t}
\] (8)

Combining Eqs. 8 and 7 provides an expression to describe the effect of x-ray source energy and beam hardening on the effective attenuation coefficients of materials which is measured using a polychromatic x-ray source and an x-ray camera:

\[
\mu_{\text{eff}} = \frac{\alpha E_b + c^+}{1 + \lambda \cdot t} \cdot \rho
\] (9)

The various attenuation coefficients illustrated in Fig. 4 are analogous to another material behavior more familiar to the civil engineering community, namely the various measurements of elastic modulus. In this analogy the initial average attenuation coefficient coincides with the initial tangent elastic modulus, the average attenuation coefficient with the tangent elastic modulus, and the effective attenuation coefficient with the secant elastic modulus.

Figs. 3(c) and 4 indicate the potential for error in x-ray attenuation measurements if an incorrect attenuation coefficient of water is used. Results from the study presented in the second part of this paper further indicate the attenuation coefficient of water is affected by the type and thickness of the porous specimen.

2.3. Composite concept for assessment of concentration changes

Commonly, changes in moisture content (or changes in concentration of other materials [e.g., corrosion products 23]) in a porous building material are described as the composite system shown in Fig. 1(b). Here an x-ray photon beam with initial intensity, \( I \), reduces to a...
transmitted intensity through a wet material, $I_{\text{wet}}$, in two drops: 1) some photons interact with the dry (or partially saturated) porous material resulting in a dry transmitted intensity, $I_{\text{dry}}$, and 2) additional photons interact with a water layer with thickness $t_w$, equivalent to the material’s water content resulting in a wet transmitted intensity, $I_{\text{wet}}$. The composite system simulates water uptake by increasing the equivalent water thickness, while drying corresponds to a reduction in water thickness. Using Eq. 2 and assuming interactions between x-ray photons and the dry porous material only influence the quantity of photons (and not photon energy), $I_{\text{wet}}$ may be expressed as:

$$I_{\text{wet}} = I_{\text{dry}} \cdot e^{-\mu_w t_w} = I_0 \cdot e^{-\mu t} \cdot e^{-\mu_w t_w} = I_0 \cdot e^{-\mu\left(t + t_w\right)} \quad (10)$$

for a monochromatic beam, and as derived in [8, 14] moisture content changes can be directly calculated by measurements of $I_{\text{dry}}$ and $I_{\text{wet}}$ according to Eq. 11:

$$\Delta w = -\frac{\rho_w}{\rho_{\text{w}}} \cdot \ln \left(\frac{I_{\text{wet}}}{I_{\text{dry}}}\right) \quad (11)$$

where $\Delta w$ is a change in moisture content [kg/m$^3$], $\rho_w$ the density of water [kg/m$^3$], and $\mu_w$ is the linear attenuation coefficient of water. Decreases in moisture content (i.e., drying) can also be directly calculated by Eq. 11 by inverting $\frac{I_{\text{dry}}}{I_{\text{wet}}}$ to $\frac{I_{\text{wet}}}{I_{\text{dry}}}$.

Eq. 11 also provides a measure of the ability to resolve changes in concentration using the x-ray attenuation measurement technique, which is defined as the change in concentration required to attenuate a single x-ray photon. Eq. 12, from [14], describes concentration resolution mathematically.

$$R_{\Delta w} = -\frac{\rho_w}{\mu_w} \cdot \ln \left(\frac{I_{\text{dry}}}{I_{\text{wet}}} - 1\right) \quad (12)$$

Eqs. 11 and 12 are central to the quantification of moisture contents in porous materials by x-ray attenuation, and both make use of the attenuation coefficient of water. Typically the non-interactive composite concept is accepted and the effective attenuation coefficient of water is either determined in isolation without interference from the porous material or, in many cases, experimental descriptions do not adequately describe which measure of attenuation coefficient of water is used for calculations of changes in moisture content [12, 14, 15, 21, 22]. This paper will show the former to be incorrect and indicates the latter requires more attention in future implementations of the x-ray attenuation measurement technique.

3. Experimental program

The goal of the experiments presented in this paper was to investigate whether an interaction exists between the attenuation provided by the porous material and the stored water. The effect of type and thickness of the parent material was investigated. Details on the materials tested, the x-ray measurement system, and measurements conducted are provided in the following sections.

3.1. Materials

Materials tested included various porous building materials, acrylic, steel, and aluminium. Porous materials included aerated autoclaved concrete, calcium silicate, clay brick, cement paste, concrete, and wood. Specimens with varying thicknesses were created either by stacking individual thin plates of the material (e.g., acrylic, aluminium, or brick) or by cutting (e.g., cement paste, clay brick). Aalborg white portland cement was used in cement paste and concrete specimens. The cement paste (0.40 water-to-cement ratio) was cured submerged in water for 28 days. Additional details on the concrete used is available in the literature [16, 20].

3.2. X-ray facility

A GNI x-ray system located at the Technical University of Denmark [34], consisting of an x-ray source and camera affixed to three programmable axes, was used for all measurements described here.

The x-ray camera consisted of a 25x25 mm$^2$ cadmium telluride (CdTe) semiconductor detector bump bonded to 252x256 16-bit complementary metal-oxide semiconductor (CMOS) pixel circuits [35]. CdTe, a direct conversion x-ray detector, converts x-ray photons to electric signals and is capable of doing so at room temperatures. The 64,512 (252x256) CMOS pixel circuits record the location and number of photons detected over a set period of time, called the integration time (analogous to shutter time in visible-light photography). The number of photons detected during the integration time is the transmitted intensity, $I$ (Eq. 2). CMOS pixel depth (maximum recordable $I$) was 65,536 (i.e., $2^{16}$); therefore, integration times must be selected to avoid ‘overfilling’ pixels. The x-ray camera used is described in detail in [35].

Beyond transmitted x-ray photons, the x-ray camera detects background radiation sources, largely in the form of dark current. Other background sources (naturally occurring radioisotopes, cosmic rays, etc.) are minimal due to the materials tested and shielding chamber. Trial measurements of dark current indicated time and temperature variations, therefore, dark current was...
4. Results

4.1. Initial intensity of x-ray photon beam

Fig. 5 shows measured values of average initial x-ray photon intensity per second as measured by the x-ray camera (average of intensities measured by the 64,512 pixels) for varying x-ray source current and energies. Eq. 13, which relates initial intensity to x-ray source current, $i$ and energy, $E_m$, was found to accurately fit measured initial intensity:

$$I_0 = (C_1 \cdot i) \cdot (C_2 \cdot E_m^4 + C_3 \cdot E_m^3 + C_4 \cdot E_m^2 + C_5 \cdot E_m + C_6)$$

where $C_1$–$C_6$ are fitting parameters shown in Table 1. Eq. 13 is a polynomial fitting of measured results and therefore is only applicable for the investigated x-ray source inputs (i.e., $30 \leq E_m \leq 85$ keV and $20 \leq i \leq 70$ µA). This expression and the values for the coefficients may not be directly transferrable to other x-ray sources; however is only applicable for the investigated x-ray source inputs (i.e., $30 \leq E_m \leq 85$ keV and $20 \leq i \leq 70$ µA).

![Figure 5: Contour plot of the initial intensity $I_0$ as a function of the input x-ray source energy and current. The blue contour lines indicate measured values, while red contours indicate calculated values from Eq. 13.](image)

Table 1: Values of coefficients $C_1$–$C_6$ in Eq. 13.

<table>
<thead>
<tr>
<th>Fitting coefficient</th>
<th>Value</th>
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</thead>
<tbody>
<tr>
<td>$C_1$</td>
<td>-0.0187</td>
</tr>
<tr>
<td>$C_2$</td>
<td>$1.502 \times 10^{-4}$</td>
</tr>
<tr>
<td>$C_3$</td>
<td>-0.0800</td>
</tr>
<tr>
<td>$C_4$</td>
<td>2.0283</td>
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<tr>
<td>$C_5$</td>
<td>1.0607</td>
</tr>
<tr>
<td>$C_6$</td>
<td>1.00236</td>
</tr>
</tbody>
</table>

4.2. Effective attenuation coefficients of materials

Fig. 6 illustrates the typical effects of x-ray source energy and materials thickness on effective attenuation coefficient, $\mu_{eff}$. Measured values in Fig. 6 are indicated by symbols, while fits provided by Eq. 9 are shown as the solid lines. Table 2 provides values for $\alpha$, $b^*$, $c^*$, $\lambda$, along with coefficients of determination ($R^2$) of the resulting fits. Fig. 6(a) indicates $\mu_{eff}$-values decrease as x-ray source energy, $E_m$ increases, and that the x-ray source energy-effect can be accurately estimated by Eq. 7 proposed in Sect. 2.2. Fig. 6(b) shows $\mu_{eff}$-values may be affected by material thickness, depending on the type of material. For example, the thickness of wood has a minimal impact on $\mu_{eff}$-values, while increased clay brick thickness causes significant reductions in $\mu_{eff}$-values.

Figs. 7(a)–(d), which illustrate both the material thickness, $t$ and x-ray source energy, $E_m$ effects on $\mu_{eff}$-values, show measured and fitted (using Eq. 9) $\mu_{eff}$-values for water, calcium silicate, clay brick, and aluminum, respectively. Measurement points are indicated by blue symbols with the measured $\mu_{eff}$-values indicated by the adjacent number. The red isolines show the fitted $\mu_{eff}$-values provided by Eq. 9. Fitting parameters are provided for all materials in Table 2, including water. The impact of hardening coefficient, $\lambda$ is
4.3. Coupled effect of parent material on effective attenuation coefficient of water

Fig. 8(a) indicates the influence of water and parent material thickness on measured values of the effective attenuation coefficient of water, $\mu_{\text{eff},w}$. Calcium silicate in various thicknesses (0, 0.02, 0.04, and 0.08 m) was used as the parent material in this case while water thickness was also varied (approximately 0.01, 0.02, 0.04, and 0.06 m). While the effect of the parent material’s thickness is evident, no clear trend was identified concerning the impact of water thickness. Increasing the water thickness from 0.01 to 0.02 appears to result in an increased $\mu_{\text{eff},w}$-value, followed by a subsequent decrease with increased water thickness. Measurement variability may explain the apparent differences with water thickness. However, Fig. 8(a) clearly shows a coupling effect of the thickness of the calcium silicate on the effective attenuation coefficient of water. Therefore, the term coupled effective attenuation coefficient of water, $\mu_{\text{eff},w}(t)$, which is a function of the parent material thickness, $t$, is introduced here.

Fig. 8(b) shows this coupling effect of the parent material on the effective attenuation coefficient of water occurs for all porous materials tested. The symbols in Fig. 8(b) indicate measured effective attenuation coefficients of water when the x-ray photon beam passed through varying thickness of the various parent materials prior to interacting with the water. As shown in the figure, the measured effective attenuation coefficient of water decreases from an average of 24.6 m$^{-1}$ for a 0 mm thickness of parent material to as low as 17.8 m$^{-1}$ for a 23.6 mm thickness of cement paste. It should be noted that values of $\mu_{\text{eff},w}(t)$ presented in Fig. 8(b) were measured using a constant 0.02 m thickness of water as Fig. 8(a) indicates water thickness is of less importance. The exponential decay model described in Eq. 14 was found to accurately fit measurements:

$$
\mu_{\text{eff},w}(t) = \mu_{\text{eff},w}(\infty) + \left[ \mu_{\text{eff},w}(0) - \mu_{\text{eff},w}(\infty) \right] \cdot e^{-\eta \cdot t} \tag{14}
$$

where, $\mu_{\text{eff},w}(\infty)$ is the coupled effective attenuation coefficient of water through an infinite thickness of the parent material [m$^{-1}$], $\mu_{\text{eff},w}(0)$ is the coupled effective attenuation coefficient through a zero thickness of the parent material [m$^{-1}$], and $\eta$ is the parent material’s coupling effect [m$^{-1}$]. The lines in Fig. 8(b) indicate the fits provided by Eq. 14 for the various parent materials. Table 3 lists the fitted values for coefficients and the coefficients of determination for the fits provided by Eq. 14.
Figure 7: Comparison of measured and estimated (Eq. 9) effective attenuation coefficients for (a) water, (b) calcium silicate, (c) clay brick, and (d) aluminium as function of specimen thickness and x-ray source energy. Blue data points indicate measured points, while the red broken isolines indicate fitted values from Eq. 9.
Table 2: Values for parameters in Eq. 9 for various materials including the coefficient of determination ($R^2$) of the fits.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Materials</th>
<th>Acrylic</th>
<th>Aerated concrete</th>
<th>Aluminium</th>
<th>Clay brick</th>
<th>Calcium silicate</th>
<th>Cement paste</th>
<th>Concrete</th>
<th>Wood</th>
<th>Water</th>
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<td>1000</td>
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<td>3999.8</td>
<td>3112.8</td>
<td>4442.7</td>
<td>5228.4</td>
<td>6750.4</td>
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<td></td>
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</tr>
<tr>
<td>$c^*$</td>
<td></td>
<td>0.022</td>
<td>0.075</td>
<td>0.060</td>
<td>0.052</td>
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<td>$\lambda$ [m$^{-1}$]</td>
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<td></td>
<td>0.861</td>
<td>0.913</td>
<td>0.948</td>
<td>0.990</td>
<td>0.976</td>
<td>0.991</td>
<td>0.953</td>
<td>0.999</td>
<td>0.987</td>
</tr>
</tbody>
</table>

Figure 8: (a) Influence of water thickness on measured coupled attenuation coefficient of water with an x-ray source energy of 85 keV measured through calcium silicate parent specimen with varying thickness and (b) coupled attenuation coefficient of water with an x-ray source energy of 85 keV with varying types and thicknesses of parent materials with symbols indicating measured values and lines indicating fits provided by Eq. 14.

Table 3: Values for parameters in Eq. 14 for various materials including the coefficient of determination ($R^2$) of the fits.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Materials</th>
<th>Acrylic</th>
<th>Aerated concrete</th>
<th>Aluminium</th>
<th>Clay brick</th>
<th>Calcium silicate</th>
<th>Cement paste</th>
<th>Concrete</th>
<th>Wood</th>
<th>Water</th>
</tr>
</thead>
<tbody>
<tr>
<td>$\mu_{eff,w}(\infty)$</td>
<td></td>
<td>21.6</td>
<td>19.5</td>
<td>18.5</td>
<td>18.0</td>
<td>18.6</td>
<td>17.5</td>
<td>118.2</td>
<td>22.4</td>
<td></td>
</tr>
<tr>
<td>$\mu_{eff,w}(0)$</td>
<td></td>
<td>24.63</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$\eta$</td>
<td></td>
<td>62.9</td>
<td>64.0</td>
<td>185.2</td>
<td>60.7</td>
<td>17.7</td>
<td>145.3</td>
<td>120.1</td>
<td>75.1</td>
<td></td>
</tr>
<tr>
<td>$R^2$</td>
<td></td>
<td>0.989</td>
<td>0.975</td>
<td>0.995</td>
<td>0.995</td>
<td>0.991</td>
<td>0.999</td>
<td>0.999</td>
<td>0.943</td>
<td></td>
</tr>
</tbody>
</table>
Comparison of results in Fig. 8(b) showing the coupling effect of the various porous materials and values for the hardening coefficient, \( \lambda \) of the porous materials presented in Table 2 indicates a potential relationship. Fig. 9 assesses this relationship, where the coupling effect is defined in accordance with Eq. 14 as

\[
\ln \left( \frac{I_w(t)}{I_{\text{eff, }w}} \right) = \eta \cdot \ln \left( \frac{I_{\text{in}}}{{I_{\text{dry}}}} \right)
\]

where \( \mu_{\text{eff, }w}(t) \) is the parent material thickness-dependent (coupled) effective attenuation coefficient of water. The coupled effective attenuation coefficient of water therefore must be directly measured for individual investigations, and tabulated values for \( \mu_w \) must be avoided. The following procedure describes one method for determining values of \( \mu_{\text{eff, }w}(t) \) when using a polychromatic x-ray photon source:

1. Measure the transmitted intensity through a conditioned (partially saturated or dried) specimen with given material type and thickness and an empty thin-walled acrylic (or similar) container with known inner dimensions at user-defined x-ray source setting(s), or \( I_c \).
2. Fill the acrylic container with water or another material investigated (e.g., corrosion products [23]) and again measure the transmitted intensity through the conditioned specimen, acrylic, and water at the same x-ray source setting(s), \( I_f \).
3. Calculate the coupled effective attenuation coefficient of water as the quotient of \(- \ln \left( \frac{I_f}{I_c} \right)\) over the water thickness, \( t_w \).

Fig. 9: Hardening coefficient, \( \lambda \) of the parent materials versus the coupling effect of the parent material on the coupled effective attenuation coefficient of water.
for the linear attenuation coefficient of water at 60 keV, 20.6 m$^{-1}$; the effective attenuation coefficient of water at 60 keV, 27.6 m$^{-1}$ (according to Eq. 9 and the fitting parameters presented in Table 2); and the coupled effective attenuation coefficient, measured to be 23.7 m$^{-1}$. Differences in moisture content (from correct values calculated using the coupled effective attenuation coefficient) as large as 31.8 kg/m$^3$ were found in this case.

Eqs. 11 and 15 indicate difference in the calculated moisture content are inversely proportional to the various attenuation coefficients. Table 4 provides an overview of the percentage difference that would result from using incorrect attenuation coefficients of the various building materials for determination of $\mu_{eff, w}(t)$-values. As shown in Fig. 8, the water thickness $t_w$ used for determination of $\mu_{eff, w}(t)$-values appears to have a minimal impact. However, the water thickness should likely closely resemble the expected maximum change in moisture content of the parent material. In this way the determination of $\mu_{eff, w}(t)$ will also act as a check to ensure the x-ray source settings and specimen thickness selected will be able to detect anticipated changes in moisture content.

Using the results presented above, the measurement resolution can be calculated using Eq. 16. Values for $I_{dry}$ are computed using Eq. 1, where $I_0$ is determined from Eq. 13 and values for $\mu_{eff}$ of the various porous materials determined using Eq. 9 and the regression coefficients in Table 2. Fig. 11 shows the concentration resolutions possible for the various parent materials using an x-ray source energy of 85 keV and current of 70 $\mu$A. The curves consider the beam hardening caused by the parent materials and the coupling effect on the effective attenuation coefficients of water, which occurs when polychromatic x-ray sources are used. For cement paste and clay brick optimal thicknesses are discovered, whereas for the other materials increasing the specimen thickness continues to improve measurement resolution for the studied conditions.

$$R_{\Delta w} = \frac{\rho_w}{\mu_{eff, w}(t) \cdot t} \ln \left( \frac{I_{dry} - 1}{I_{dry}} \right)$$

(16)
6. Summary and conclusions

This paper presents a detailed description of the controlling mechanism behind x-ray attenuation measurement using both monochromatic and polychromatic x-ray sources and non-energy discretizing x-ray cameras. Differences in measurements taken with monochromatic and polychromatic sources are described. Various attenuation coefficients, including linear, average, effective, and coupled effective (for water only), were defined and described in order to shed light on possible mistakes made in previous investigations. It is concluded that using tabulated values of the linear attenuation coefficient, $\mu_w$, of water should not be used for calculating moisture content changes.

Additionally, a parametric investigation on material type, thickness and x-ray source energy settings on the ability to resolve changes in moisture content was presented. Results obtained through the parametric studies performed on aluminium, acrylic, clay brick, aerated autoclaved concrete, cement paste, concrete, calcium silicate, and wood indicated that:

- The effective attenuation coefficient of water is affected by the type and thickness of the parent specimen, necessitating the introduction of the coupled effective attenuation coefficient of water, $\mu_{\text{eff},w}(t)$. Therefore, when utilizing the x-ray attenuation measurement technique to calculate moisture content (or other material concentration) changes, the attenuation coefficient of water must be directly measured while the parent specimen is in place. A procedure for determining $\mu_{\text{eff},w}(t)$ is presented.
- It was found that calculations of change in moisture content (i.e., Eq. 15) may vary by up to 26.9% if the incorrect attenuation coefficient of water is used.
- Material-dependent optimization functions – in terms of ability to resolve water – have been developed for clay brick, aerated autoclaved concrete, cement paste, concrete, calcium silicate, and wood. These functions consider specimen thickness, x-ray source energy and current, beam hardening caused by the parent material, and the coupled effective attenuation coefficient of water. This extensive study provides a simple means for determination of proper specimen size and x-ray energy settings for a variety of materials.

### Acknowledgements

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### References


Nomenclature

\( \alpha \) Fitting parameter equivalent to \( a^+ \cdot Z_{eff}^{-3.8} \) [-]

\( \Delta \omega \) Change in moisture content [kg/m²]

\( \eta \) Parent material coupling effect [m⁻¹]

\( \kappa \) Pair production cross-section [m⁻¹]

\( \lambda \) Beam hardening coefficient [m⁻¹]

\( \mu \) Linear attenuation coefficient [m⁻¹]

\( \mu_0 \) Initial average attenuation coefficient [m⁻¹]

\( \mu_{w} \) Linear attenuation coefficient of water [m⁻¹]

\( \mu_{eff,w} \) Effective attenuation coefficient of water [m⁻¹]

\( \mu_{eff,w}(0) \) Coupled effective attenuation coefficient of water with 0 m thickness of parent material, fitted [m⁻¹]
\( \mu_{\text{eff},w}(\infty) \) Coupled effective attenuation coefficient of water with infinite thickness of parent material, fitted

\[ [\text{m}^{-1}] \]

\( \mu_{\text{eff},w}(t) \) Coupled effective attenuation coefficient of water

\( [\text{m}^{-1}] \)

\( \mu_{\text{eff}} \) Effective attenuation coefficient \([\text{m}^{-1}]\)

\( \bar{\mu} \) Average attenuation coefficient \([\text{m}^{-1}]\)

\( \Psi_E \) Shape of photon energy spectrum [-]

\( \rho \) Density \([\text{kg/m}^3]\)

\( \rho_w \) Density of water \([\text{kg/m}^3]\)

\( \sigma \) Compton cross-section \([\text{m}^{-1}]\)

\( \tau \) Photoelectric cross-section \([\text{m}^{-1}]\)

\( a \) Fitting parameter describing photoelectric cross-section [-]

\( a^* \) Fitting parameter describing effective photoelectric cross-section [-]

\( b \) Fitting parameter describing photoelectric cross-section [-]

\( b^* \) Fitting parameter describing effective photoelectric cross-section [-]

\( c \) Fitting parameter describing Compton cross-section [-]

\( c^* \) Fitting parameter describing effective Compton cross-section [-]

\( C_{1-6} \) Fitting parameters [-]

\( E \) X-ray photon energy \([\text{keV}]\)

\( E_m \) X-ray source energy (maximum photon energy produced by polychromatic x-ray source) \([\text{keV}]\)

\( f_i \) Fraction of element \(i\) [-]

\( I \) Transmitted intensity \([\text{counts}]\)

\( i \) X-ray source current \([\mu\text{A}]\)

\( I_0 \) Initial intensity \([\text{counts}]\)

\( I_d \) Transmitted intensity through parent material and empty container \([\text{counts}]\)

\( I_w \) Transmitted intensity through parent material and container filled with water or other substance being investigated \([\text{counts}]\)

\( R_{\Delta w} \) Resolution of change in moisture content \([\text{kg/m}^3]\)

\( t \) Parent material (specimen) thickness \([\text{m}]\)

\( t_w \) Thickness of water \([\text{m}]\)

\( x \) Incremental thickness \([\text{m}]\)

\( Z_{\text{eff}} \) Effective atomic number [-]. \( Z_{\text{eff}} = \sqrt[3.8]{\sum f_i Z_i^{3.8}} \)

\( Z_i \) Atomic number of element \(i\) [-]